CT/FCT TEST PROBES

Test Probe **GKS-075 214 100 A 2000**

O TO PRODUCT



Item GKS-075-0008

- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles





Test Probe GKS-075 214 100 A 2000

Item GKS-075-0008

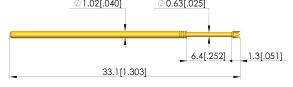




General data

Product group ICT / FCT (in-circuit test and function test Sub-product group Standard stroke test probe Series GKS-075 Grid 1.91 mm [75 mil] Contacting from Pad, Pin, Post Magnetic Yes Installation type Plug-in Quick-exchange system Yes Adjustable installation height No Non-rotating No Compatible receptacle(s) KS-075 Min. temperature - 40 °C [- 104 °F] Max. temperature + 80 °C [+ 176 °F] RoHS-compliant Yes







Electrical data

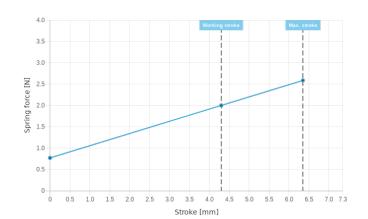
Current load capacity / rated current 3 A Typical resistance (Ri) <20 mOhm

Mechanical data

Total length 33.1 mm [1.30 in] Barrel diameter 1.02 mm [.040 in] Maximum stroke 6.35 mm [.25 in] Spring pre-load 0.77 N [2.76 ozf] Collar height 00 Spring force at working stroke 2 N [7.19 ozf] Recommended working stroke 4.3 mm [.169 in]

Tip style data

Tip style 14 4-point crown, self-cleaning Tip diameter 1 mm [.039 in] A gold Tip style surface Tip style material 2 steel



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Weitere Informationen zum Thema ICT/FCT Test probes

